


<b>Search Notes</b> 	<b>Application/Control No.</b> 10706445	<b>Applicant(s)/Patent Under Reexamination</b> SHINKAI ET AL.
	<b>Examiner</b> tWendmagegn, Girumsew	<b>Art Unit</b> 2621

SEARCHED			
Class	Subclass	Date	Examiner
386	52	10/14/2008	gw
725	115	10/14/2008	gw
725	93	10/14/2008	gw
725	145	10/14/2008	gw

SEARCH NOTES		
Search Notes	Date	Examiner
US-PGPUB;USPAT;USOCR;EPO;JPO;DERWENT;IBM_TDB	10/8/2008	gw
Inventor(s) search	10/14/2008	gw
NPL: google( metadata WITH editing)	6/22/2007	gw

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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